


<b>Search Notes</b>  	<b>Application/Control No.</b>  10527757	<b>Applicant(s)/Patent Under Reexamination</b>  SCHOTT ET AL.
	<b>Examiner</b>  Tsz K Chiu	<b>Art Unit</b>  2822

SEARCHED			
Class	Subclass	Date	Examiner
257	208,210,252,347,401,421-427	6/08/08	TC

SEARCH NOTES		
Search Notes	Date	Examiner
Discussed with Primary examiner Mary Wilczewski	6/7/08	TC
updated search	12/18/09	TC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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